

Search Notes

Application/Control No.

09/784,112

Examiner

Shefali D. Patel

Applicant(s)/Patent under
Reexamination

TAKEO, HIDEYA

Art Unit

2621

SEARCHED

Class	Subclass	Date	Examiner
382	128	<i>Updated</i> (9/6/2005)	(SDP)

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST IEEE see search printout	<i>Updated</i> (9/6/2005)	(SDP)